

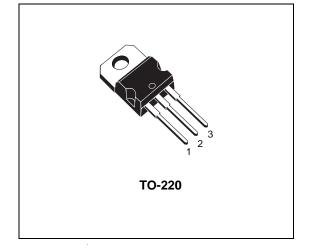
BUL310

HIGH VOLTAGE FAST-SWITCHING NPN POWER TRANSISTOR

- STMicroelectronics PREFERRED SALESTYPE
- NPN TRANSISTOR
- HIGH VOLTAGE CAPABILITY
- LOW SPREAD OF DYNAMIC PARAMETERS
- MINIMUM LOT-TO-LOT SPREAD FOR RELIABLE OPERATION
- VERY HIGH SWITCHING SPEED
- FULLY CHARACTERISED AT 125°C
- LARGE RBSOA

APPLICATIONS

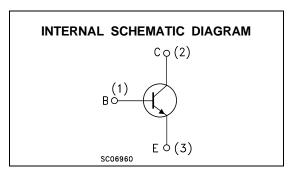
- ELECTRONIC BALLASTS FOR FLUORESCENT LIGHTING
- FLYBACK AND FORWARD SINGLE TRANSISTOR LOW POWER CONVERTERS



DESCRIPTION

The device is manufactured using high voltage Multi Epitaxial Planar technology for high switching speeds and high voltage capability. It uses a Cellular Emitter structure with planar edge termination to enhance switching speeds while maintaining a wide RBSOA.

The BUL series is designed for use in lighting applications and low cost switch-mode power supplies.



ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V _{CES}	Collector-Emitter Voltage (V _{BE} = 0)	1000	V
V_{CEO}	Collector-Emitter Voltage (I _B = 0)	500	V
V _{EBO}	Emitter-Base Voltage (I _C = 0)	9	V
Ic	Collector Current	5	V
I _{CM}	Collector Peak Current (t _p <5 ms)	10	А
Ι _Β	Base Current	3	А
I_{BM}	Base Peak Current (t _p <5 ms)	4	А
P _{tot}	Total Dissipation at Tc = 25 °C	75	W
T _{stg}	Storage Temperature	-65 to 150	°C
Tj	Max. Operating Junction Temperature	150	°C

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THERMAL DATA

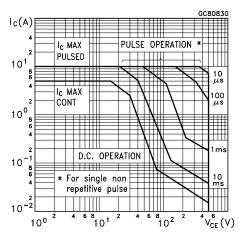
R _{th}	nj-case	Thermal	Resistance	Junction-Case	Max	1.65	°C/W
Rth	nj-amb	Thermal	Resistance	Junction-Ambient	Max	62.5	°C/W

ELECTRICAL CHARACTERISTICS (T_{case} = 25 °C unless otherwise specified)

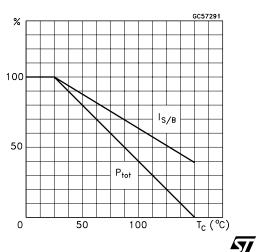
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
I _{CES}	Collector Cut-off Current (V _{BE} = 0)	V _{CE} = 1000 V V _{CE} = 1000 V T _j = 125 °C			100 500	μA μA
I _{CEO}	Collector Cut-off Current (I _B = 0)	V _{CE} = 500 V			250	μΑ
V _{CEO(sus)*}	Collector-Emitter Sustaining Voltage (I _B = 0)	I _C = 100 mA	500			V
V _{EBO}	Emitter-Base Voltage (I _C = 0)	I _E = 10 mA	9			V
V _{CE(sat)} *	Collector-Emitter Saturation Voltage				0.5 0.7 1.1	V V V
V _{BE(sat)} *	Base-Emitter Saturation Voltage	I _C = 1 A I _B = 0.2 A I _C = 2 A I _B = 0.4 A I _C = 3 A I _B = 0.6 A			1 1.1 1.2	V V V
h _{FE} *	DC Current Gain	I _C = 10 mA V _{CE} = 5 V I _C = 3 A V _{CE} = 2.5 V	10 6	10	14	
t _s t _f	INDUCTIVE LOAD Storage Time Fall Time	$\begin{array}{ll} I_{C} = 2 \; A & I_{B1} = 0.4 \; A \\ V_{BE(off)} = -5 \; V & R_{BB} = 0 \; \Omega \\ V_{CL} = 250 \; V & L = 200 \; \mu H \\ (see figure 1) & \end{array}$		1.2 80	1.9 160	μs ns
t _s t _f	INDUCTIVE LOAD Storage Time Fall Time	$\begin{array}{lll} I_{C} = 2 \; A & I_{B1} = 0.4 \; A \\ V_{BE(off)} = \text{-5V} & R_{BB} = 0 \; \Omega \\ V_{CL} = 250 \; V & L = 200 \; \mu\text{H} \\ T_{j} = 125 \; ^{\text{O}}\text{C} & (\text{see figure 1}) \end{array}$		1.8 150		μs ns

^{*} Pulsed: Pulse duration = 300 μ s, duty cycle 1.5 %

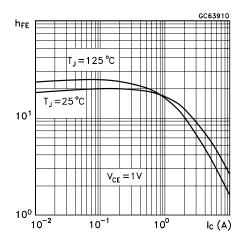
Safe Operating Areas



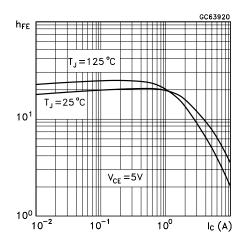
Derating Curve



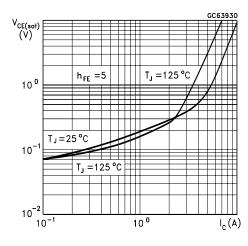
DC Current Gain



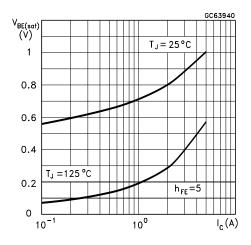
DC Current Gain



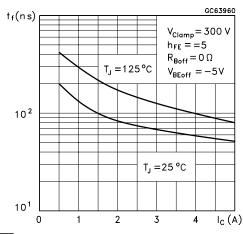
Collector Emitter Saturation Voltage



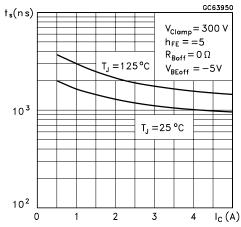
Base Emitter Saturation Voltage



Inductive Load Fall Time



Inductive Load Storage Time



Reverse Biased SOA

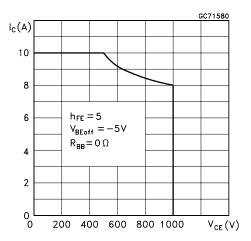
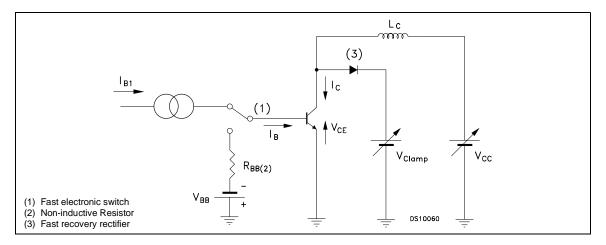
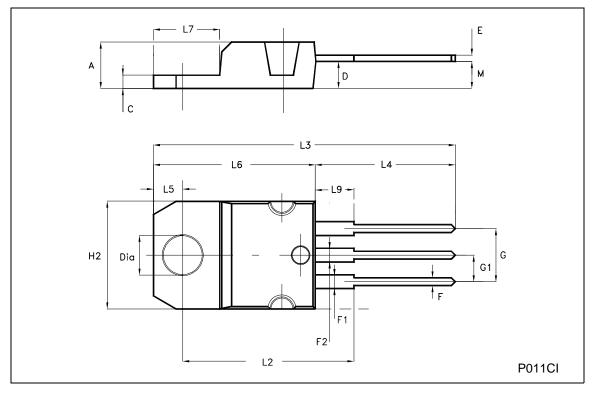


Figure 1: Inductive Load Switching Test Circuit



TO-220 MECHANICAL DATA

DIM	mm			inch			
DIM.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	
Α	4.40		4.60	0.173		0.181	
С	1.23		1.32	0.048		0.052	
D	2.40		2.72	0.094		0.107	
Е	0.49		0.70	0.019		0.027	
F	0.61		0.88	0.024		0.034	
F1	1.14		1.70	0.044		0.067	
F2	1.14		1.70	0.044		0.067	
G	4.95		5.15	0.194		0.202	
G1	2.40		2.70	0.094		0.106	
H2	10.00		10.40	0.394		0.409	
L2		16.40			0.645		
L4	13.00		14.00	0.511		0.551	
L5	2.65		2.95	0.104		0.116	
L6	15.25		15.75	0.600		0.620	
L7	6.20		6.60	0.244		0.260	
L9	3.50		3.93	0.137		0.154	
М		2.60			0.102		
DIA.	3.75		3.85	0.147		0.151	



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